Application/Control No. Applicant(s)/Patent Under Reexamination 10/651,663 XIE, FEI Notice of References Cited Art Unit Examiner Page 1 of 1 2618 Yuwen Pan **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY * US-71366130 11-2006 Fei Xie 455/412.1 Α US-В US-С US-D US-Ε US-US-G US-Н US-US-US-Κ US-L US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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